











LMH6654, LMH6655

SNOS956E - JUNE 2001 - REVISED AUGUST 2014

LMH6654, LMH6655 Single and Dual Low Power, 250 MHz, Low Noise Amplifiers

Features

- $(V_S = \pm 5 \text{ V}, T_J = 25 ^{\circ}\text{C}, \text{Typical Values Unless})$
- Voltage Feedback Architecture
- Unity Gain Bandwidth 250 MHz
- Supply Voltage Range ±2.5V to ±6V
- Slew Rate 200 V/µsec
- Supply Current 4.5 mA/channel
- Input Common Mode Voltage -5.15V to +3.7V
- Output Voltage Swing ($R_1 = 100 \Omega$) -3.6V to 3.4V
- Input Voltage Noise 4.5 nV/√Hz
- Input Current Noise 1.7 pA/√Hz
- Settling Time to 0.01% 25 ns

Applications

- **ADC Drivers**
- Consumer Video
- Active Filters
- Pulse Delay Circuits
- xDSL Receiver
- Pre-amps

3 Description

The LMH6654 and LMH6655 single and dual high speed voltage feedback amplifiers are designed to have unity-gain stable operation with a bandwidth of 250 MHz. They operate from ±2.5 V to ±6 V and each channel consumes only 4.5 mA. The amplifiers feature very low voltage noise and wide output swing to maximize signal-to-noise ratio, and possess a true single supply capability with input common mode voltage range extending 150 mV below negative rail and within 1.3 V of the positive rail. The high speed and low power combination of the LMH6654 and LMH6655 make these products an ideal choice for many portable, high speed applications where power is at a premium.

The LMH6654 and LMH6655 are built on TI's Advance VIP10™ (Vertically Integrated complementary bipolar process.

The LMH6654 is packaged in 5-Pin SOT-23 and 8-Pin SOIC. The LMH6655 is packaged in 8-Pin VSSOP (DGK) and 8-Pin SOIC.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
LMH6654	SOIC (8)	4.90 mm x 3.91 mm
LMH6654	SOT-23 (5)	2.90 mm x 1.60 mm
LMH6655	SOIC (8)	4.90 mm x 3.91 mm
LMH6655	VSSOP (8)	3.00 mm x 3.00 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

Figure 1. Input Voltage and Curernt Noise vs. Frequency ($V_s = \pm 5V$)

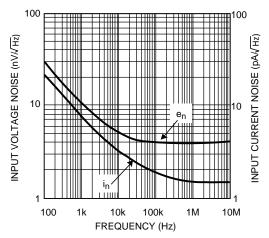




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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

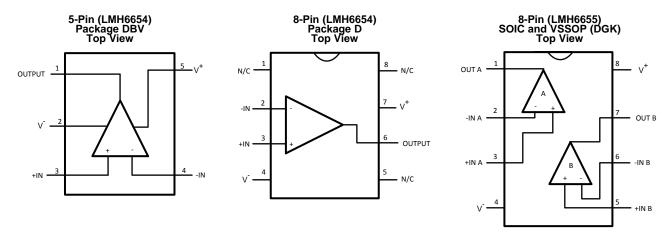
C	hanges from Revision D (March 2013) to Revision E	Page
•	Changed data sheet structure and organization. Added, updated, or renamed the following sections: Device Information Table, Application and Implementation; Power Supply Recommendations; Device and Documentation Support; Mechanical, Packaging, and Ordering Information. Deleted Switching Characteristics due to redundancy.	1
•	Changed from Junction Temperature Range to "Operating Temperature Range"	4
•	Deleted T _J = 25°C	5
<u>•</u>	Deleted T _J = 25°C	7
C	hanges from Revision C (March 2013) to Revision D	Page
•	Changed layout of National Data Sheet to TI format	19

Product Folder Links: LMH6654 LMH6655

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5 Pin Configuration and Functions



Pin Functions

		PIN			
NAME	LMH6654		LMH6655 I/O	DESCRIPTION	
NAIVIE	DBV	D	DGK		
-IN	4	2		I	Inverting Input
+IN	3	3		1	Non-inverting Input
-IN A			2	I	ChA Inverting Input
+IN A			3	I	ChA Non-inverting Input
-IN B			6	I	ChB Inverting Input
+IN B			5	- 1	ChB Non-inverting Input
N/C		1, 5, 8		_	No Connection
OUT A			1	0	ChA Output
OUT B			7	0	ChB Output
OUTPUT	1	6		0	Output
V-	2	4	4	I	Negative Supply
V ⁺	5	7	8	I	Positive Supply



6 Specifications

6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

		MIN	MAX	UNIT
V _{IN} Differential			±1.2	V
Output Short Circuit Duration		See (2)		
Supply Voltage (V ⁺ - V ⁻)			13.2	V
Voltage at Input pins			V ⁺ +0.5 V⁻ -0.5	V
Junction Temperature(3)		150	°C
Caldavia e lafa esa atia e	Infrared or Convection (20 sec.)		235	°C
Soldering Information	Wave Soldering (10 sec.)		260	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 Handling Ratings

			MIN	MAX	UNIT
T _{stg}	Storage temperature range		-65	150	°C
V _(ESD)	Electrostatic discharge (1)	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽²⁾		2000	٧
(=32)	_	Machine model (MM) ⁽³⁾		200	

⁽¹⁾ Human body model, 1.5 k Ω in series with 100 pF. Machine model: 0 Ω in series with 100 pF.

6.3 Recommended Operating Conditions⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

	MIN	NOM MAX	UNIT
Supply Voltage (V ⁺ - V ⁻)	±2.5	±6.0	V
Operating Temperature Range	-40	85	ô

⁽¹⁾ Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is intended to be functional, but specific performance is not ensured. For ensured specifications and the test conditions, see the Electrical Characteristics Table.

6.4 Thermal Information

	THERMAL METRIC ⁽¹⁾ Junction-to-ambient thermal resistance	SOIC (D)	VSSOP (DGK)	SOT-23 (D)	UNIT	
	I TERMAL METRIC	8 PINS	8 PINS	5 PINS	UNII	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	172	235	265	°C/W	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report, SPRA953.

⁽²⁾ Continuous short circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature at 150°C.

⁽³⁾ The maximum power dissipation is a function of $T_{J(MAX)}$, $R_{\theta JA}$ and T_A . The maximum allowable power dissipation at any ambient temperature is $P_D = (T_{J(MAX)} - T_A)/R_{\theta JA}$. All numbers apply for packages soldered directly onto a PC board.

⁽²⁾ JEDEC document JEP155 states that 2000-V HBM allows safe manufacturing with a standard ESD control process.

⁽³⁾ JEDEC document JEP157 states that 200-V MM allows safe manufacturing with a standard ESD control process.



6.5 ±5V Electrical Characteristics

Unless otherwise specified, all limits ensured for $V^+ = +5V$, $V^- = -5V$, $V_{CM} = 0V$, $A_V = +1$, $R_F = 25\Omega$ for gain = +1, $R_F = 402\Omega$ for gain $\geq +2$, and $R_L = 100\Omega$. **Boldface** limits apply at the temperature extremes.

	PARAMETER	TEST CONDITIONS	MIN ⁽¹⁾	TYP ⁽²⁾	MAX ⁽¹⁾	UNIT
DYNAMIC	PERFORMANCE					
		A _V = +1		250		
,	0	A _V = +2		130		
f _{CL}	Close Loop Bandwidth	A _V = +5		52		MHz
		A _V = +10		26		
	Gain Bandwidth Product	A _V ≥ +5		260		MHz
GBWP	Bandwidth for 0.1 dB Flatness	A _V +1		18		MHz
φm	Phase Margin			50		deg
SR	Slew Rate (3)	$A_V = +1, V_{IN} = 2 V_{PP}$		200		V/µs
t _S	Settling Time 0.01%	A _V = +1, 2V Step		25		ns
3	0.1%			15		ns
t _r	Rise Time	$A_V = +1, 0.2V \text{ Step}$		1.4		ns
t _f	Fall Time	$A_V = +1, 0.2V \text{ Step}$		1.2		ns
DISTORT	ION and NOISE RESPONSE		1			
e _n	Input Referred Voltage Noise	f ≥ 0.1 MHz		4.5		nV/√ Hz
i _n	Input-Referred Current Noise	f ≥ 0.1 MHz		1.7		pA/√ Hz
	Second Harmonic Distortion	$A_V = +1, f = 5 \text{ MHz}$		-80		
	Third Harmonic Distortion	$V_{O} = 2 V_{PP}, R_{L} = 100\Omega$		-85		dBc
X _t	Crosstalk (for LMH6655 only)	Input Referred, 5 MHz, Channel-to-Channel		-80		dB
DG	Differential Gain	$A_V = +2$, NTSC, $R_L = 150\Omega$		0.01%		
DP	Differential Phase	$A_V = +2$, NTSC, $R_L = 150\Omega$		0.025		deg
INPUT CI	HARACTERISTICS		II.		I	
V _{OS}	Input Offset Voltage	V _{CM} = 0V	-3 -4	±1	3 4	mV
TC V _{OS}	Input Offset Average Drift	$V_{CM} = 0V^{(4)}$		6		μV/°C
I _B	Input Bias Current	V _{CM} = 0V		5	12 18	μΑ
I _{OS}	Input Offset Current	V _{CM} = 0V	-1 -2	0.3	1 2	μΑ
D	Innut Decistones	Common Mode		4		МΩ
R _{IN}	Input Resistance	Differential Mode		20		kΩ
	Innut Conscitones	Common Mode		1.8		
C _{IN}	Input Capacitance	Differential Mode		1		pF
CMRR	Common Mode Rejection Ration	Input Referred, V _{CM} = 0V to −5V	70 68	90		dB
CMVD	Input Common Mode Veltage Design	CMPD > 50 dP		- 5.15	-5.0	17
CMVR	Input Common- Mode Voltage Range	CMRR ≥ 50 dB	3.5	3.7		V
TRANSFI	ER CHARACTERISTICS				- 1	
A _{VOL}	Large Signal Voltage Gain	$V_{O} = 4 V_{PP}, R_{L} = 100\Omega$	60 58	67		dB

All limits are specified by testing or statistical analysis. Typical Values represent the most likely parametric norm.

Slew rate is the slower of the rising and falling slew rates. Slew rate is rate of change from 10% to 90% of output voltage step.

Offset voltage average drift is determined by dividing the change in V_{OS} at temperature extremes into the total temperature change.



±5V Electrical Characteristics (continued)

Unless otherwise specified, all limits ensured for $V^+ = +5V$, $V^- = -5V$, $V_{CM} = 0V$, $A_V = +1$, $R_F = 25\Omega$ for gain = +1, $R_F = 402\Omega$ for gain \geq +2, and $R_L = 100\Omega$. **Boldface** limits apply at the temperature extremes.

	PARAMETER	TEST CONDITIONS	MIN ⁽¹⁾	TYP ⁽²⁾	MAX ⁽¹⁾	UNIT
OUTPUT	CHARACTERISTICS					
	Output Swing High	No Load	3.4 3.2	3.6		
Vo	Output Swing Low	No Load		-3.9	−3.7 −3.5	V
	Output Swing High	$R_L = 100\Omega$	3.2 3.0	3.4		
	Output Swing Low	R _L = 100Ω		-3.6	-3.4 -3.2	
	Short Circuit Current ⁽⁵⁾	Sourcing, $V_O = 0V$ $\Delta V_{IN} = 200 \text{ mV}$	145 130	280		A
Isc		Sinking, $V_O = 0V$ $\Delta V_{IN} = 200 \text{ mV}$	100 80	185		mA
	Outrot Comment	Sourcing, V _O = +3V		80		A
I _{OUT}	Output Current	Sinking, $V_0 = -3V$		120		mA
R _O	Output Resistance	$A_V = +1$, f <100 kHz		0.08		Ω
POWER	SUPPLY	•			·	
PSRR	Power Supply Rejection Ratio	Input Referred, V _S = ±5V to ±6V	60	76		dB
I _S	Supply Current (per channel)			4.5	6 7	mA

⁽⁵⁾ Continuous short circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature at 150°C.

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6.6 5V Electrical Characteristics

Unless otherwise specified, all limits ensured for $V^+ = +5V$, $V^- = -0V$, $V_{CM} = 2.5V$, $A_V = +1$, $R_F = 25 \Omega$ for gain = +1, $R_F = 402\Omega$ for gain $\ge +2$, and $R_L = 100\Omega$ to $V^+/2$. **Boldface** limits apply at the temperature extremes.

	PARAMETER	TEST CONDITIONS	MIN ⁽¹⁾	TYP ⁽²⁾	MAX ⁽¹⁾	UNIT
DYNAMIC	PERFORMANCE				'	
		A _V = +1		230		
,	Olasa I. aar Baada idh	A _V = +2		120		N 41 1-
f_{CL}	Close Loop Bandwidth	A _V = +5		50		MHz
		A _V = +10		25		
GBWP	Gain Bandwidth Product	A _V ≥ +5		250		MHz
	Bandwidth for 0.1 dB Flatness	A _V = +1		17		MHz
φm	Phase Margin			48		deg
SR	Slew Rate (3)	A _V = +1, V _{IN} = 2 V _{PP}		190		V/µs
t _S	Settling Time 0.01%	A _V = +1, 2V Step		30		ns
J	0.1%			20		ns
t _r	Rise Time	A _V = +1, 0.2V Step		1.5		ns
t _f	Fall Time	A _V = +1, 0.2V Step		1.35		ns
DISTORT	TON and NOISE RESPONSE	,				
e _n	Input Referred Voltage Noise	f ≥ 0.1 MHz		4.5		nV/√ Hz
i _n	Input Referred Current Noise	f ≥ 0.1 MHz		1.7		pA/√ Hz
	Second Harmonic Distortion	A _V = +1, f = 5 MHz		-65		JD.
	Third Harmonic Distortion	$V_{O} = 2 V_{PP}, R_{L} = 100\Omega$		-70		dBc
X _t	Crosstalk (for LMH6655 only)	Input Referred, 5 MHz		-78		dB
INPUT C	HARACTERISTICS					
Vos	Input Offset Voltage	V _{CM} = 2.5V	-5 -6.5	±2	5 6.5	mV
TC V _{OS}	Input Offset Average Drift	$V_{CM} = 2.5V^{(4)}$		6		μV/°C
I _B	Input Bias Current	V _{CM} = 2.5V		6	12 18	μΑ
I _{OS}	Input Offset Current	V _{CM} = 2.5V	-2 -3	0.5	2 3	μΑ
R _{IN}	Input Resistance	Common Mode		4		ΜΩ
NIN	input Resistance	Differential Mode		20		kΩ
C···	Input Capacitance	Common Mode		1.8		pF
C _{IN}	при Сараспапсе	Differential Mode		1		ρι
CMRR	Common Mode Rejection Ration	Input Referred, V _{CM} = 0V to −2.5V	70 68	90		dB
CMVR	Input Common Mode Voltage Range	CMRR ≥ 50 dB		-0.15	0	V
CIVIVI	input Common wode voltage Kange		3.5	3.7		V
TRANSFI	ER CHARACTERISTICS					
A _{VOL}	Large Signal Voltage Gain	$V_{O} = 1.6 V_{PP}, R_{L} = 100\Omega$	58 55	64		dB

⁽¹⁾ All limits are specified by testing or statistical analysis.

Typical Values represent the most likely parametric norm.

Slew rate is the slower of the rising and falling slew rates. Slew rate is rate of change from 10% to 90% of output voltage step.

Offset voltage average drift is determined by dividing the change in VOS at temperature extremes into the total temperature change.



5V Electrical Characteristics (continued)

Unless otherwise specified, all limits ensured for $V^+ = +5V$, $V^- = -0V$, $V_{CM} = 2.5V$, $A_V = +1$, $R_F = 25~\Omega$ for gain = +1, $R_F = 402\Omega$ for gain $\ge +2$, and $R_L = 100\Omega$ to $V^+/2$. **Boldface** limits apply at the temperature extremes.

	PARAMETER	TEST CONDITIONS	MIN ⁽¹⁾	TYP ⁽²⁾	MAX ⁽¹⁾	UNIT
OUTPUT	CHARACTERISTICS					
	Output Swing High	No Load	3.6 3.4	3.75		
Vo	Output Swing Low	No Load		0.9	1.1 1.3	V
	Output Swing High	R _L = 100Ω	3.5 3.35	3.70		
	Output Swing Low	$R_L = 100\Omega$		1	1.3 1.45	
	Short Circuit Current ⁽⁵⁾	Sourcing , $V_O = 2.5V$ $\Delta V_{IN} = 200 \text{ mV}$	90 80	170		A
I _{SC}	Short Circuit Current (9)	Sinking, $V_O = 2.5V$ $\Delta V_{IN} = 200 \text{ mV}$	70 60	140		mA
	Outrast Ourset	Sourcing, $V_O = +3.5V$		30		A
I _{OUT}	Output Current	Sinking, V _O = 1.5V		60		mA
R _O	Output Resistance	$A_V = +1$, f <100 kHz		.08		Ω
POWER	SUPPLY		- !		'	
PSRR	Power Supply Rejection Ratio	Input Referred , V _S = ± 2.5V to ± 3V	60	75		dB
Is	Supply Current (per channel)			4.5	6 7	mA

⁽⁵⁾ Continuous short circuit operation at elevated ambient temperature can result in exceeding the maximum allowed junction temperature at 150°C.



6.7 Typical Characteristics

25°C, V⁺ = ±5 V, V⁻ = −5, R_F = 25 Ω for gain = +1, R_F = 402 Ω for gain ≥ +2 and R_L = 100 Ω , unless otherwise specified.

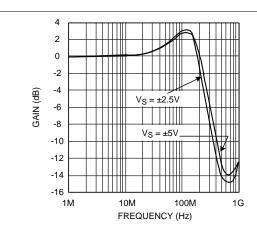


Figure 2. Closed Loop Bandwidth (G = +1)

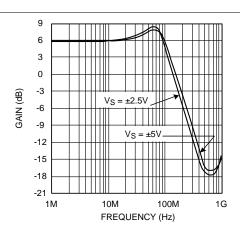


Figure 3. Closed Loop Bandwidth (G = +2)

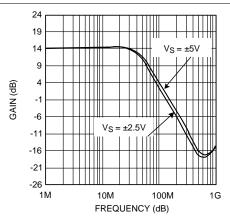


Figure 4. Closed Loop Bandwidth (G = +5)

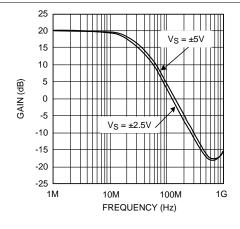


Figure 5. Closed Loop Bandwidth (G = +10)

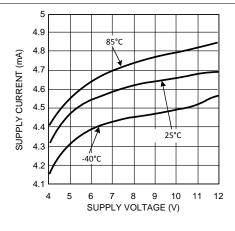


Figure 6. Supply Current per Channel vs. Supply Voltage

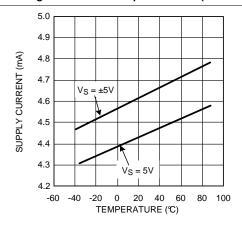
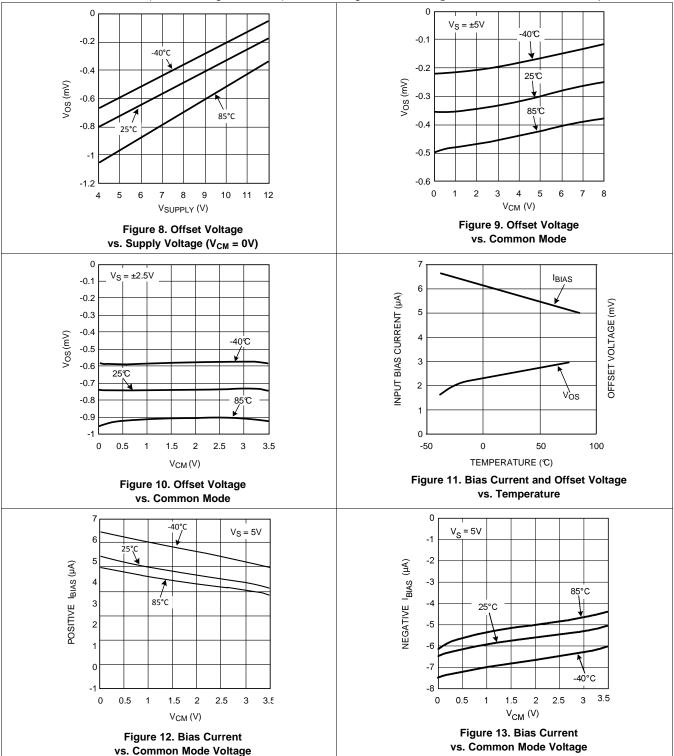


Figure 7. Supply Current per Channel vs. Temperature

TEXAS INSTRUMENTS

Typical Characteristics (continued)

25°C, V⁺ = ±5 V, V⁻ = −5, R_F = 25 Ω for gain = +1, R_F = 402 Ω for gain ≥ +2 and R_L = 100 Ω , unless otherwise specified.



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Typical Characteristics (continued)

25°C, V⁺ = ±5 V, V⁻ = −5, R_F = 25 Ω for gain = +1, R_F = 402 Ω for gain ≥ +2 and R_L = 100 Ω , unless otherwise specified.

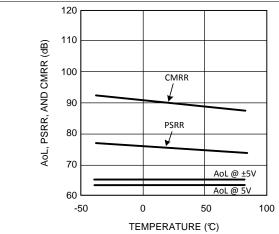
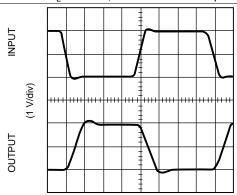
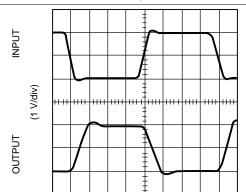


Figure 14. A_{OL}, PSRR and CMRR vs. Temperature



TIME (12.5 ns/div)

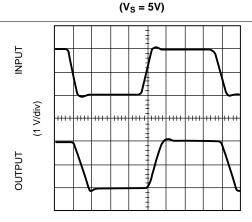
Figure 15. Inverting Large Signal Pulse Response



TIME (12.5 ns/div)

Figure 16. Inverting Large Signal Pulse Response

(V_S = ±5V)



TIME (12.5 ns/div) Figure 17. Non-Inverting Large Signal Pulse Response $(V_S = 5V)$

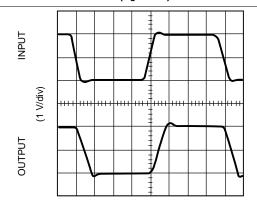
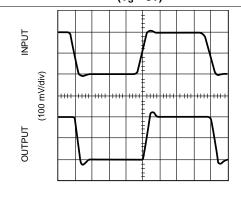


Figure 18. Non-Inverting Large Signal Pulse Response $(V_S = \pm 5V)$

TIME (12.5 ns/div)



TIME (12.5 ns/div)

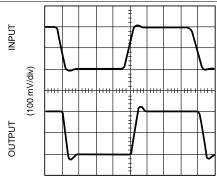
Figure 19. Non-Inverting Small Signal Pulse Response $(V_S = 5V)$

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TEXAS INSTRUMENTS

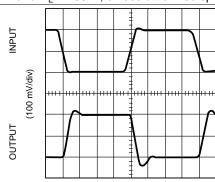
Typical Characteristics (continued)

25°C, V⁺ = ±5 V, V⁻ = −5, R_F = 25 Ω for gain = +1, R_F = 402 Ω for gain ≥ +2 and R_L = 100 Ω , unless otherwise specified.



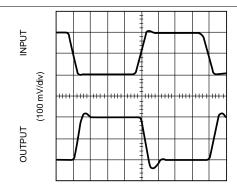
TIME (12.5 ns/div)

Figure 20. Non-Inverting Small Signal Pulse Response $(V_S = \pm 5V)$



TIME (12.5 ns/div)

Figure 21. Inverting Small Signal Pulse Response $(V_S = 5V)$



TIME (12.5 ns/div)

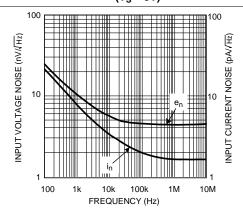
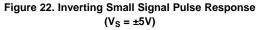


Figure 23. Input Voltage and Current Noise vs. Frequency (V_S = 5V)



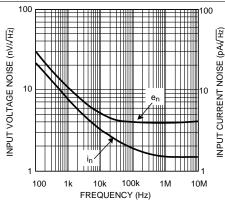


Figure 24. Input Voltage and Current Noise vs. Frequency ($V_S = \pm 5V$)

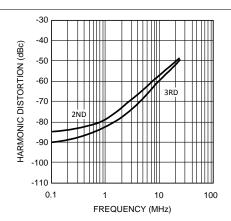


Figure 25. Harmonic Distortion vs. Frequency G = +1, V_O = 2 V_{PP}, V_S = 5V

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Typical Characteristics (continued)

25°C, V⁺ = ±5 V, V⁻ = −5, R_F = 25 Ω for gain = +1, R_F = 402 Ω for gain ≥ +2 and R_L = 100 Ω , unless otherwise specified.

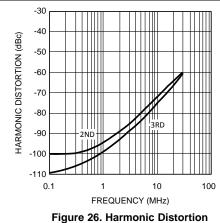


Figure 26. Harmonic Distortion vs. Frequency $G = +1, V_O = 2 V_{PP}, V_S = \pm 5V$

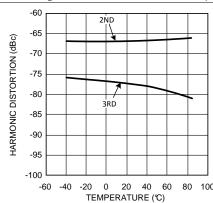


Figure 27. Harmonic Distortion vs. Temperature $V_S = 5V$, f = 5 MHz, $V_O = 2$ V_{PP}

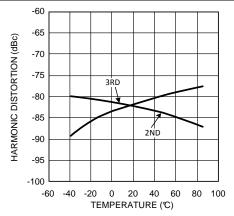


Figure 28. Harmonic Distortion vs. Temperature $V_S = \pm 5V$, f = 5 MHz, $V_O = 2$ V_{PP}

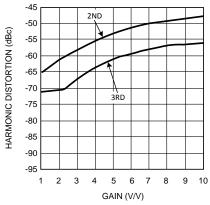


Figure 29. Harmonic Distortion vs. Gain $V_S = 5V$, f = 5 MHz, $V_O = 2$ V_{PP}

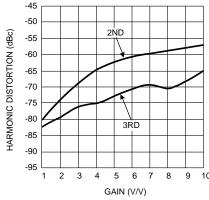


Figure 30. Harmonic Distortion vs. Gain $V_S = \pm 5V$, f = 5 MHz, $V_O = 2$ V_{PP}

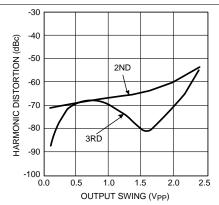


Figure 31. Harmonic Distortion vs. Output Swing (G = +2, V_S = 5V, f = 5 MHz)

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TEXAS INSTRUMENTS

Typical Characteristics (continued)

25°C, V⁺ = ±5 V, V⁻ = −5, R_F = 25 Ω for gain = +1, R_F = 402 Ω for gain ≥ +2 and R_L = 100 Ω , unless otherwise specified.

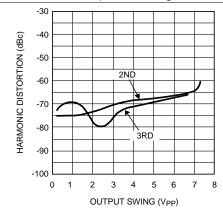


Figure 32. Harmonic Distortion vs. Output Swing

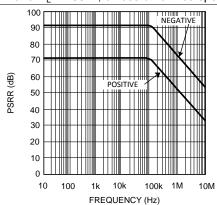


Figure 33. PSRR vs. Frequency

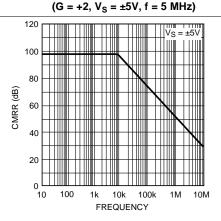


Figure 34. CMRR vs. Frequency

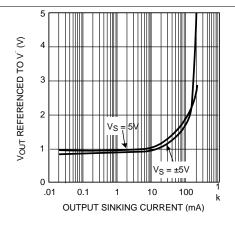


Figure 35. Output Sinking Current

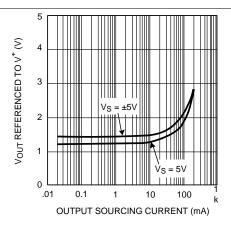


Figure 36. Output Sourcing Current

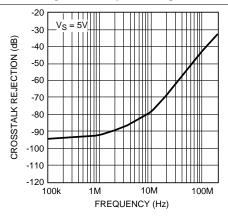


Figure 37. CrossTalk vs. Frequency (LMH6655 only)

Submit Documentation Feedback

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Typical Characteristics (continued)

25°C, V⁺ = ±5 V, V⁻ = −5, R_F = 25 Ω for gain = +1, R_F = 402 Ω for gain ≥ +2 and R_L = 100 Ω , unless otherwise specified.

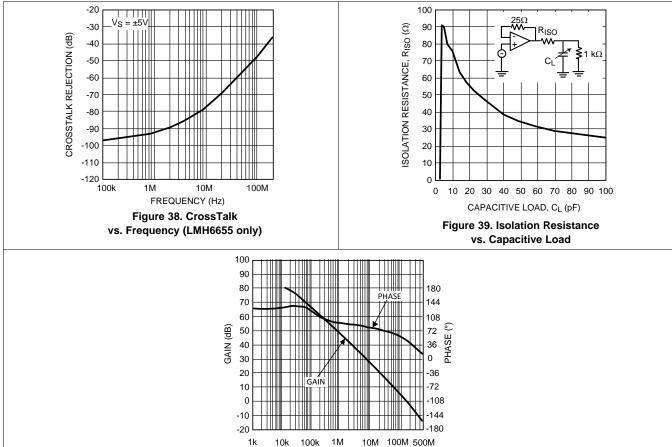


Figure 40. Open Loop Gain and Phase vs. Frequency

FREQUENCY (Hz)

Product Folder Links: LMH6654 LMH6655

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7 Application and Implementation

7.1 Application Information

The LMH6654 single and LMH6655 dual high speed, voltage feedback amplifiers are manufactured on TI's new VIP10™ (Vertically Integrated PNP) complementary bipolar process. These amplifiers can operate from ±2.5 V to ±6 V power supply. They offer low supply current, wide bandwidth, very low voltage noise and large output swing. Many of the typical performance plots found in the datasheet can be reproduced if 50 Ω coax and 50 Ω R_{IN}/R_{OUT} resistors are used.

7.2 Typical Application

7.2.1 Design Requirements

7.2.1.1 Components Selection and Feedback Resistor

It is important in high-speed applications to keep all component leads short since wires are inductive at high frequency. For discrete components, choose carbon composition axially leaded resistors and micro type capacitors. Surface mount components are preferred over discrete components for minimum inductive effect. Never use wire wound type resistors in high frequency applications.

Large values of feedback resistors can couple with parasitic capacitance and cause undesired effects such as ringing or oscillation in high-speed amplifiers. Keep resistors as low as possible consistent with output loading consideration. For a gain of 2 and higher, 402 Ω feedback resistor used for the typical performance plots gives optimal performance. For unity gain follower, a 25 Ω feedback resistor is recommended rather than a direct short. This effectively reduces the Q of what would otherwise be a parasitic inductance (the feedback wire) into the parasitic capacitance at the inverting input.

7.2.2 Detailed Design Procedure

7.2.2.1 Driving Capacitive Loads

Capacitive loads decrease the phase margin of all op amps. The output impedance of a feedback amplifier becomes inductive at high frequencies, creating a resonant circuit when the load is capacitive. This can lead to overshoot, ringing and oscillation. To eliminate oscillation or reduce ringing, an isolation resistor can be placed as shown in Figure 41 below. At frequencies above

$$F = \frac{1}{2 \pi R_{ISO} C_{LOAD}}$$
 (1)

the load impedance of the Amplifier approaches R_{ISO}. The desired performance depends on the value of the isolation resistor. The isolation resistance vs. capacitance load graph in the typical performance characteristics provides the means for selection of the value of R_s that provides ≤ 3 dB peaking in closed loop $A_V = 1$ response. In general, the bigger the isolation resistor, the more damped the pulse response becomes. For initial evaluation, a 50Ω isolation resistor is recommended.

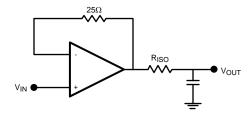


Figure 41. Isolation Resistor Placement



Typical Application (continued)

7.2.2.2 Bias Current Cancellation

In order to cancel the bias current errors of the non-inverting configuration, the parallel combination of the gain setting R_g and feedback R_f resistors should equal the equivalent source resistance R_{seq} as defined in Figure 42. Combining this constraint with the non-inverting gain equation, allows both R_f and R_g to be determined explicitly from the following equations:

$$R_f = A_V R_{seq}$$
 and $R_g = R_f / (A_V - 1)$ (2)

For inverting configuration, bias current cancellation is accomplished by placing a resistor R_b on the non-inverting input equal in value to the resistance seen by the inverting input $(R_f/(R_g+R_s))$. The additional noise contribution of R_b can be minimized through the use of a shunt capacitor.

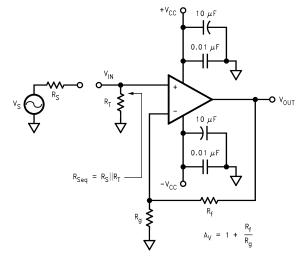


Figure 42. Non-Inverting Amplifier Configuration

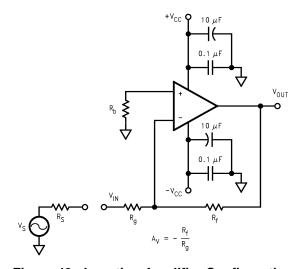


Figure 43. Inverting Amplifier Configuration



Typical Application (continued)

7.2.2.3 Total Input Noise vs. Source Resistance

The noise model for the non-inverting amplifier configuration showing all noise sources is described in Figure 44. In addition to the intrinsic input voltage noise (e_n) and current noise $(i_n = i_{n+} = i_{n-})$ sources, there also exits thermal voltage noise $e_t = \sqrt{4kTR}$ associated with each of the external resistors. Equation 3 provides the general form for total equivalent input voltage noise density (e_{ni}) . Equation 4 is a simplification of Equation 3 that assumes $R_f \parallel R_g = R_{seq}$ for bias current cancellation. Figure 45 illustrates the equivalent noise model using this assumption. The total equivalent output voltage noise (e_{no}) is $e_{ni} * A_V$.

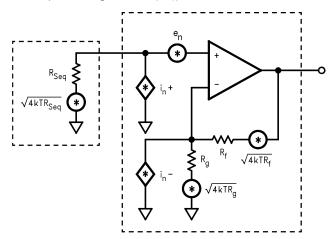


Figure 44. Non-Inverting Amplifier Noise Model

$$e_{ni} = \sqrt{e_n^2 + (i_{n+} \cdot R_{Seq})^2 + 4kTR_{Seq} + (i_{n-} \cdot (R_f || R_g))^2 + 4kT(R_f || R_g)}$$

$$\sqrt{4kT2R_{Seq}}$$

$$2 R_{Seq}$$

$$\frac{i_n}{\sqrt{2}}$$

$$(3)$$

Figure 45. Noise Model with $R_f \parallel R_q = R_{seq}$

$$e_{ni} = \sqrt{e_n^2 + 2(i_n \cdot R_{Seq})^2 + 4kT(2R_{Seq})}$$
 (4)

If bias current cancellation is not a requirement, then $R_f \parallel R_g$ does not need to equal R_{seq} . In this case, according to Equation 3, R_f and R_g should be as low as possible in order to minimize noise. Results similar to Equation 3 are obtained for the inverting configuration on if R_{seq} is replaced by $R_b \parallel R_g$ is replaced by $R_g + R_s$. With these substitutions, Equation 3 will yield an e_{ni} referred to the non-inverting input. Referring e_{ni} to the inverting input is easily accomplished by multiplying e_{ni} by the ratio of non-inverting to inverting gains.



Typical Application (continued)

7.2.2.3.1 Noise Figure

Noise Figure (NF) is a measure of the noise degradation caused by an amplifier.

NF = 10LOG
$$\left[\frac{S_i/N_i}{S_0/N_0}\right] = 10LOG \left[\frac{e_{ni}^2}{e_t^2}\right]$$
 (5)

The noise figure formula is shown in Equation 5. The addition of a terminating resistor R_T , reduces the external thermal noise but increases the resulting NF.

The NF is increased because the R_T reduces the input signal amplitude thus reducing the input SNR.

$$\left[\frac{e_{n}^{2} + i_{n}^{2} (R_{Seq} + (R_{f} || R_{g}))^{2} + 4KTR_{Seq} + 4kt (R_{f} || R_{g})}{4kTR_{Seq}}\right]$$
(6)

The noise figure is related to the equivalent source resistance (R_{seq}) and the parallel combination of R_f and R_g . To minimize noise figure, the following steps are recommended:

- 1. Minimize $R_f || R_a$
- 2. Choose the Optimum R_s (R_{OPT})

R_{OPT} is the point at which the NF curve reaches a minimum and is approximated by:

$$R_{OPT} \approx (e_n/i_n)$$

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8 Power Supply Recommendations

8.1 Power Dissipation

The package power dissipation should be taken into account when operating at high ambient temperature and/or high power dissipative conditions. In determining maximum operable temperature of the device, make sure the total power dissipation of the device is considered; this power dissipated in the device with a load connected to the output as well as the nominal dissipation of the op amp.

9 Layout

9.1 Layout Guidelines

With all high frequency devices, board layouts with stray capacitance have a strong influence on the AC performance. The LMH6654/LMH6655 are not exception and the inverting input and output pins are particularly sensitive to the coupling of parasitic capacitance to AC ground. Parasitic capacitances on the inverting input and output nodes to ground could cause frequency response peaking and possible circuit oscillation. Therefore, the power supply, ground traces and ground plan should be placed away from the inverting input and output pins. Also, it is very important to keep the parasitic capacitance across the feedback to an absolute minimum.

The PCB should have a ground plane covering all unused portion of the component side of the board to provide a low impedance path. All trace lengths should be minimized to reduce series inductance.

Supply bypassing is required for the amplifiers performance. The bypass capacitors provide a low impedance return current path at the supply pins. They also provide high frequency filtering on the power supply traces. It is recommended that a ceramic decoupling capacitor 0.1 µF chip should be placed with one end connected to the ground plane and the other side as close as possible to the power pins. An additional 10 µF tantalum electrolytic capacitor should be connected in parallel, to supply current for fast large signal changes at the output.

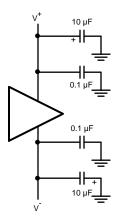


Figure 46. Supply Bypass Capacitors

9.1.1 Evaluation Boards

TI provides the following evaluation boards as a guide for high frequency layout and as an aid in device testing and characterization.

DEVICE	PACKAGE	EVALULATION BOARD PN
LMH6654MF	5-Pin SOT-23	LMH730216
LMH6654MA	8-Pin SOIC	LMH730227
LMH6655MA	8-Pin SOIC	LMH730036
LMH6655MM	8-Pin VSSOP (DGK)	LMH730123



Components Needed to Evaluate the LMH6654 on the LMH730227 Evaluation Board:

- R_f, R_a use the datasheet to select values.
- R_{IN}, R_{OUT} typically 50 Ω (Refer to the Basic Operation section of the evaluation board datasheet for details)
- R_f is an optional resistor for inverting again configurations (select R_f to yield desired input impedance = R_g||R_f)
- C₁, C₂ use 0.1 μF ceramic capacitors
- C₃, C₄ use 10 μF tantalum capacitors

Components not used:

- 1. C₅, C₆, C₇, C₈
- 2. R1 thru R8

The evaluation boards are designed to accommodate dual supplies. The board can be modified to provide single operation. For best performance;

- 1) Do not connect the unused supply.
- 2) Ground the unused supply pin.

10 Device and Documentation Support

10.1 Documentation Support

10.1.1 Related Documentation

10.1.1.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 1. Related Links

PARTS	PRODUCT FOLDER	SAMPLE & BUY	TECHNICAL DOCUMENTS	TOOLS & SOFTWARE	SUPPORT & COMMUNITY
LMH6654	Click here	Click here	Click here	Click here	Click here
LMH6655	Click here	Click here	Click here	Click here	Click here

10.2 Electrostatic Discharge Caution

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These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

10.3 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing		Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
LMH6654MA/NOPB	ACTIVE	SOIC	D	8	95	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 85	LMH66 54MA	Samples
LMH6654MAX/NOPB	ACTIVE	SOIC	D	8	2500	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 85	LMH66 54MA	Samples
LMH6654MF	LIFEBUY	SOT-23	DBV	5	1000	Non-RoHS & Green	Call TI	Level-1-260C-UNLIM	-40 to 85	A66A	
LMH6654MF/NOPB	ACTIVE	SOT-23	DBV	5	1000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 85	A66A	Samples
LMH6654MFX/NOPB	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 85	A66A	Samples
LMH6655MA	LIFEBUY	SOIC	D	8	95	Non-RoHS & Green	Call TI	Level-1-235C-UNLIM	-40 to 85	LMH66 55MA	
LMH6655MA/NOPB	ACTIVE	SOIC	D	8	95	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 85	LMH66 55MA	Samples
LMH6655MAX/NOPB	ACTIVE	SOIC	D	8	2500	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 85	LMH66 55MA	Samples
LMH6655MM/NOPB	ACTIVE	VSSOP	DGK	8	1000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 85	A67A	Samples
LMH6655MMX/NOPB	ACTIVE	VSSOP	DGK	8	3500	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 85	A67A	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



PACKAGE OPTION ADDENDUM

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- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE MATERIALS INFORMATION

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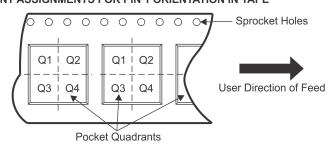
TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
LMH6654MAX/NOPB	SOIC	D	8	2500	330.0	12.4	6.5	5.4	2.0	8.0	12.0	Q1
LMH6654MF	SOT-23	DBV	5	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LMH6654MF/NOPB	SOT-23	DBV	5	1000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LMH6654MFX/NOPB	SOT-23	DBV	5	3000	178.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
LMH6655MAX/NOPB	SOIC	D	8	2500	330.0	12.4	6.5	5.4	2.0	8.0	12.0	Q1
LMH6655MM/NOPB	VSSOP	DGK	8	1000	178.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1
LMH6655MMX/NOPB	VSSOP	DGK	8	3500	330.0	12.4	5.3	3.4	1.4	8.0	12.0	Q1



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*All dimensions are nominal

Device	Package Type	Package Type Package Drawing Pins		SPQ	Length (mm)	Width (mm)	Height (mm)
LMH6654MAX/NOPB	SOIC	D	8	2500	367.0	367.0	35.0
LMH6654MF	SOT-23	DBV	5	1000	208.0	191.0	35.0
LMH6654MF/NOPB	SOT-23	DBV	5	1000	208.0	191.0	35.0
LMH6654MFX/NOPB	SOT-23	DBV	5	3000	208.0	191.0	35.0
LMH6655MAX/NOPB	SOIC	D	8	2500	367.0	367.0	35.0
LMH6655MM/NOPB	VSSOP	DGK	8	1000	208.0	191.0	35.0
LMH6655MMX/NOPB	VSSOP	DGK	8	3500	367.0	367.0	35.0

PACKAGE MATERIALS INFORMATION

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TUBE



*All dimensions are nominal

7 th difficition and from that								
Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
LMH6654MA/NOPB	D	SOIC	8	95	495	8	4064	3.05
LMH6655MA	D	SOIC	8	95	495	8	4064	3.05
LMH6655MA	D	SOIC	8	95	495	8	4064	3.05
LMH6655MA/NOPB	D	SOIC	8	95	495	8	4064	3.05



SMALL OUTLINE PACKAGE



NOTES:

PowerPAD is a trademark of Texas Instruments.

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-187.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
- 8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
- 9. Size of metal pad may vary due to creepage requirement.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 12. Board assembly site may have different recommendations for stencil design.





SMALL OUTLINE TRANSISTOR



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 2. This drawing is subject to change without notice.
 3. Reference JEDEC MO-178.

- 4. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25 mm per side.
- 5. Support pin may differ or may not be present.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE TRANSISTOR



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





SMALL OUTLINE INTEGRATED CIRCUIT



NOTES:

- 1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.
- 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 [0.15] per side.
- 4. This dimension does not include interlead flash.
- 5. Reference JEDEC registration MS-012, variation AA.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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